Se	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/696,848	DONHAM ET AL.	
Examiner	Art Unit	-
Kee M. Tung	2671	

	SEARCHED		
Class	Subclass	Date	Examiner
345	501, 506, 519, 502, 531, 522	10/18/2005	КМТ
1	552, 557	•	,
	582, 541		
	426, 418		
	564, 572	1	
4	559, 532		Ø
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
7			
		 	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
IEEE	10/19/05 10/20/05 10/18/05 10/20/05	КМТ
EAST	10/18/05	КМТ